IC Testers

Now integrated circuits are easily identified and tested with B+K Precision's new Handheld IC Testers. Two models, one for linear, one for digital ICs, are available, both with extensive built-in libraries. Small, handheld design is battery powered for portability in the field or the lab. Very large scale integration allows for advanced functionality, ease-of-use and reliable testing of hundreds of ICs. Remove the guesswork, don't wonder any longer: identify, test and verify unknown ICs, quickly and reliably. Both models operate from batteries (included) or optional AC battery pack.

		models
	570	575
POWER SOURCES		
BATTERIES	4 x 1.5V AA (not Ni-Cd)	2 x 9V
DC INPUT	6V, 300mA max.	12V, 300mA max.,
	regulated	regulated
POWER CONSUMPTION	1	
POWER OFF	10µA	2μΑ
STANDBY	10mA	30mA
TEST THRESHOLDS	Logic High: 2.2V Min.	Variable
	Logic Low: 0.8V Max.	(DAC controlled)
LIBRARY ICs*	Operational Amplifiers,	Series 54/74 TTL ICs,
	Comparators, Operational	CMOS ICs, Memory ICs,
	Amplifiers / Comparators,	Interface, Peripheral,
	Voltage Regulators, Voltage	Microprocessor & LSI IC
	References, Analog Switches /	(75 series,
	Multiplexers, Transistor Arrays,	ULN2 series,
	Optoisolators / Optocouplers,	DS88 series,
	DACS / ADSC, Special	8T series, 82 series,
	Functions ICs, Virtual Grounds,	25/26/29 series,
	Audio ICs	8MC68 series,
		MC34 series,
		Z80 series,
		MC65 series,
		Intel 80 series, etc.)
GENERAL		
STORAGE TEMPERATURE	-4° to 149°F (-20° to 65°C) <80% RH	
OPERATING TEMPERATURE	32° to 122°F (0° - 50°C) <80% RH	
DIMENSIONS (HxWxD)	7.87 x 3.94 x 2.17" (200 x 100 x 55mm)	
WEIGHT	1.1lbs. (500g)	

SUPPLIED: Instruction Manual

* Please contact factory for the complete IC support list.

Model 570 Linear IC Tester

570

Easy-to-use, no programming or fixturing required. Simply plug in the device, key in the part's number or use Auto Detect and the 570 will do the rest. Proven test software using advanced technology makes this the ideal addition to your toolkit.

- Tests all common analog IC's
- Auto identification of unmarked/housecoded devices listing possible replacements
- Conditional/unconditional loop testing mode
- Functional test emulates passive circuitry to implement a comprehensive test in a variety of configurations
- Displays diagnostic information down to individual component pins
- Rugged, hand-held, ergonomically designed case incorporates built-in membrane keypad, 2 x 16 dot matrix alpha-numeric LCD and high quality 16 pin ZIF socket
- Auto power off

Model 575 Digital IC Tester

Test a large variety of digital ICs with the 575 tester. Large built-in library offers a broad range of ICs to select from, including

575

TTL, CMOS, Memory, LSI and others. Simple single shot IC tests are easily performed by keying in the IC number on the integrated keypad. Results are displayed instantly. Search feature finds unmarked IC and displays possible functional equivalents.

- 40 pin wide-entry ZIF sockets test a broad range of TTL, CMOS Memory, LSI, Interface and other devices (NAND gates to CPUs)
- Identifies unmarked and house-coded devices
- Detects intermittent and temperature related faults
- Displays diagnostic information for individual pins